

Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All recreations are done with the approval of the OCM.

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceed the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-35835
 - Class Q Military
 - Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)
- Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OEM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.

Power MOSFET 125 A, 24 V N-Channel TO-220, D²PAK

Features

- Planar HD3e Process for Fast Switching Performance
- Body Diode for Low t_{rr} and Q_{rr} and Optimized for Synchronous Operation
- Low C_{iss} to Minimize Driver Loss
- Optimized Q_{gd} and R_{DS(on)} for Shoot-through Protection
- Low Gate Charge
- Pb-Free Packages are Available

MAXIMUM RATINGS (T_J = 25°C Unless otherwise specified)

Parameter	Symbol	Value	Unit	
Drain-to-Source Voltage	V _{DSS}	24	V_{dc}	
Gate-to-Source Voltage - Continuous	V_{GS}	±20	V_{dc}	
Thermal Resistance – Junction–to–Case Total Power Dissipation @ $T_C = 25^{\circ}C$ Drain Current – Continuous @ $T_C = 25^{\circ}C$, Chip Continuous @ $T_C = 25^{\circ}C$, Limited by Package Continuous @ $T_A = 25^{\circ}C$, Limited by Wires Single Pulse ($t_p = 10 \mu s$)	R _B C P _D ID ID ID ID	1.1 113.6 125 120.5 95 250	°C &	
Thermal Resistance – Junction–to–Ambient (Note 1) Total Power Dissipation @ T _A = 25°C Drain Current – Continuous @ T _A = 25°C	R _{θJA} P _D I _D	46 2.72 18.6	°C/W W A	
Thermal Resistance – Junction–to–Ambient (Note 2) Total Power Dissipation @ T _A = 25°C Drain Current – Continuous @ T _A = 25°C	R _{θJA} P _D I _D	63 1.98 15.9	°C/W W A	
Operating and Storage Temperature Range	T _J , T _{stg}	–55 to 150	°C	
Single Pulse Drain–to–Source Avalanche Energy – Starting T_J = 25°C (V_{DD} = 50 V_{dc} , V_{GS} = 10 V_{dc} , I_L = 15.5 A_{pk} , L = 1 mH, R_G = 25 Ω)	E _{AS}	120	mJ	
Maximum Lead Temperature for Soldering Purposes, 1/8" from Case for 10 Seconds	TL	260	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- When surface mounted to an FR4 board using 1 inch pad size, (Cu Area 1.127 in²).
- 2. When surface mounted to an FR4 board using minimum recommended pad size, (Cu Area 0.412 in²).

PIN ASSIGNMENT

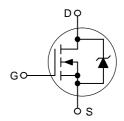
PIN	FUNCTION
1	Gate
2	Drain
3	Source
4	Drain



ON Semiconductor®

http://onsemi.com

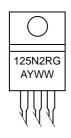
125 AMPERES, 24 VOLTS $R_{DS(on)} = 3.7 \text{ m}\Omega \text{ (Typ)}$



MARKING DIAGRAMS



TO-220AB CASE 221A STYLE 5





D²PAK CASE 418AA STYLE 2



125N2x = Device Code

x = R

A = Assembly Location

Y = Year WW = Work Week

G = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C Unless otherwise specified)

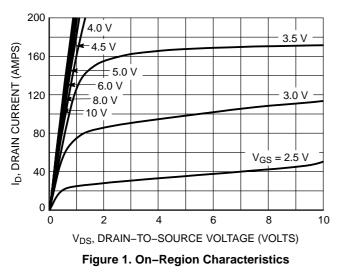
Characteristics			Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage (Note 3) $ (V_{GS} = 0 \ V_{dc}, I_D = 250 \ \mu A_{dc}) $ Temperature Coefficient (Positive)		V _{(BR)DSS}	25 -	28 15	- -	V _{dc} mV/°C
Zero Gate Voltage Drain Current $(V_{DS} = 20 V_{dc}, V_{GS} = 0 V_{dc})$ $(V_{DS} = 20 V_{dc}, V_{GS} = 0 V_{dc}, T_{J} = 125^{\circ}C)$		I _{DSS}	1 1	- -	1.5 10	μA _{dc}
Gate–Body Leakage Current (V _{GS} = ±20 V _{dc} , V _{DS} = 0 V _{dc})			_	_	±100	nA _{dc}
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage (Note 3) $ (V_{DS} = V_{GS}, I_D = 250 \ \mu A_{dc}) $ Threshold Temperature Coefficient (Negative)		V _{GS(th)}	1.0	1.5 5.0	2.0	V _{dc} mV/°C
$ \begin{array}{l} \text{Static Drain-to-Source On-Resistance (Note 3)} \\ (\text{V}_{GS} = 10 \text{ V}_{dc}, \text{ I}_{D} = 110 \text{ A}_{dc}) \\ (\text{V}_{GS} = 4.5 \text{ V}_{dc}, \text{ I}_{D} = 55 \text{ A}_{dc}) \\ (\text{V}_{GS} = 10 \text{ V}_{dc}, \text{ I}_{D} = 20 \text{ A}_{dc}) \\ (\text{V}_{GS} = 4.5 \text{ V}_{dc}, \text{ I}_{D} = 20 \text{ A}_{dc}) \end{array} $			- - -	3.7 4.9 3.7 4.7	- - 4.6 6.2	mΩ
Forward Transconductance (Note 3) (V _{DS} = 10 V _{dc} , I _D = 15 A _{dc})			-	44	_	Mhos
DYNAMIC CHARACTERISTICS						
Input Capacitance		C _{iss}	_	2710	3440	pF
Output Capacitance	$(V_{DS} = 20 V_{dc}, V_{GS} = 0 V, f = 1 MHz)$	C _{oss}	-	1105	1670	
Transfer Capacitance		C _{rss}	-	227	640	
SWITCHING CHARACTERISTICS (Not	e 4)					
Turn-On Delay Time		t _{d(on)}	_	11	22	ns
Rise Time	$(V_{GS} = 10 V_{dc}, V_{DD} = 10 V_{dc},$	t _r	-	39	80	
Turn-Off Delay Time	$I_D = 40 A_{dc}, R_G = 3 \Omega)$	t _{d(off)}	-	27	40	
Fall Time		tf	-	21	40	
Gate Charge	$(V_{GS} = 4.5 V_{dc}, I_D = 40 A_{dc},$	Q _T	_	23.6	28	nC
	$V_{DS} = 10 V_{dc}$, (Note 3)	Q_1	-	5.1	_	
			_	11	_	
SOURCE-DRAIN DIODE CHARACTERISTICS						
Forward On–Voltage	$ \begin{array}{c} (I_S = 20 A_{dc}, V_{GS} = 0 V_{dc}) (\text{Note 3}) \\ (I_S = 55 A_{dc}, V_{GS} = 0 V_{dc}) \\ (I_S = 20 A_{dc}, V_{GS} = 0 V_{dc}, T_J = 125^{\circ}\text{C}) \end{array} $	V _{SD}	- - -	0.82 0.99 0.65	1.2 - -	V _{dc}
Reverse Recovery Time		t _{rr}	-	36.5	-	ns
	$(I_S = 30 A_{dc}, V_{GS} = 0 V_{dc}, dI_S/dt = 100 A/\mu s)$ (Note 3)		ı	17.7	_]
			_	18.8	_	
Reverse Recovery Stored Charge	erse Recovery Stored Charge		_	0.024	_	μС

ORDERING INFORMATION

Device	Package	Shipping [†]
NTP125N02R	TO-220AB	50 Units / Rail
NTP125N02RG	TO-220AB (Pb-Free)	50 Units / Rail
NTB125N02R	D ² PAK	50 Units / Rail
NTB125N02RG	D ² PAK (Pb-Free)	50 Units / Rail
NTB125N02RT4	D ² PAK	800 Units / Tape & Reel
NTB125N02RT4G	D ² PAK (Pb-Free)	800 Units / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.



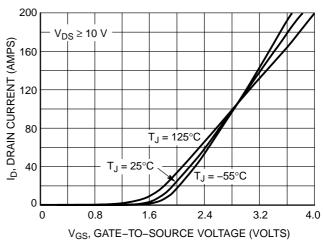
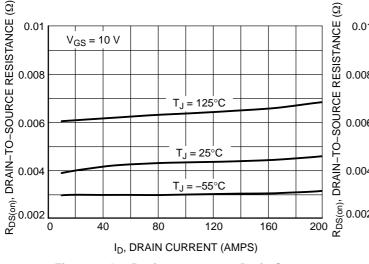


Figure 2. Transfer Characteristics



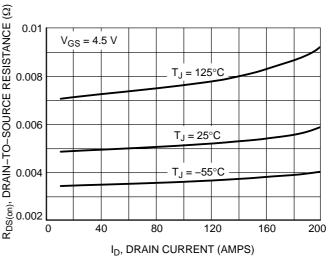
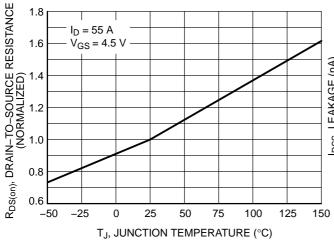


Figure 3. On–Resistance versus Drain Current and Temperature

Figure 4. On-Resistance versus Drain Current and Temperature



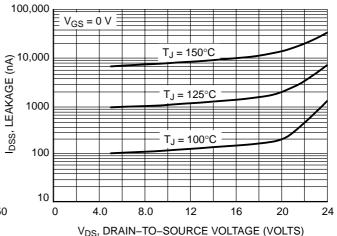
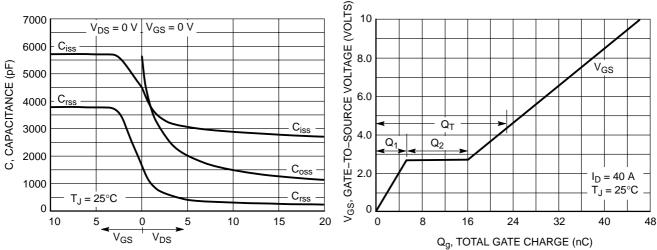


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current versus Voltage



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

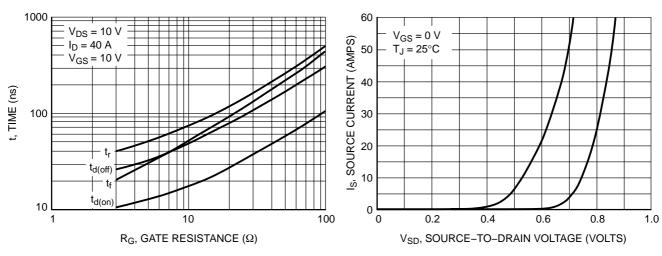


Figure 9. Resistive Switching Time Variation versus Gate Resistance

Figure 10. Diode Forward Voltage versus Current

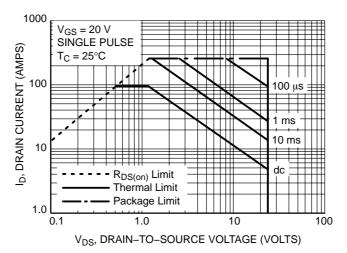


Figure 11. Maximum Rated Forward Biased Safe Operating Area

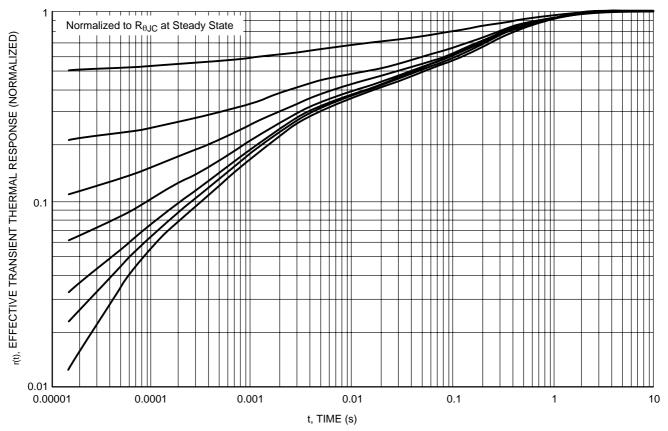
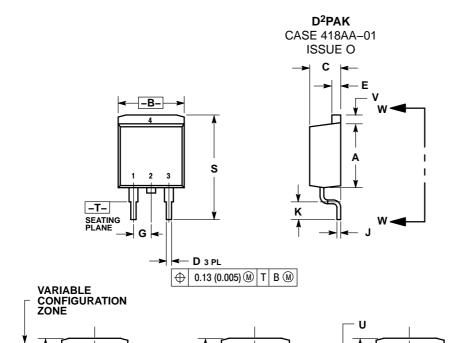


Figure 12. Thermal Response

PACKAGE DIMENSIONS



M

VIEW W-W

М

VIEW W-W

1

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

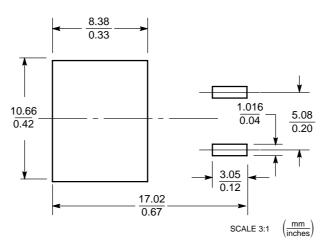
	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.340	0.380	8.64	9.65
В	0.380	0.405	9.65	10.29
С	0.160	0.190	4.06	4.83
D	0.020	0.036	0.51	0.92
E	0.045	0.055	1.14	1.40
F	0.310		7.87	
G	0.100 BSC		2.54 BSC	
J	0.018	0.025	0.46	0.64
K	0.090	0.110	2.29	2.79
M	0.280		7.11	
S	0.575	0.625	14.60	15.88
٧	0.045	0.055	1.14	1.40

- STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

3 **SOLDERING FOOTPRINT***

M

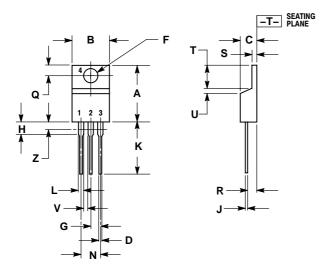
VIEW W-W



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

TO-220 CASE 221A-09 ISSUE AA



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI
 V14 5M 1982
- Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
- DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.570	0.620	14.48	15.75
В	0.380	0.405	9.66	10.28
С	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.42	2.66
Н	0.110	0.155	2.80	3.93
_	0.018	0.025	0.46	0.64
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
Т	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
٧	0.045		1.15	
Z		0.080		2.04

STYLE 5

PIN 1. GATE 2. DRAIN

3. SOURCE 4 DRAIN

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